

## MOS FIELD EFFECT TRANSISTOR

# 2SK3113

## SWITCHING N-CHANNEL POWER MOS FET

#### **DESCRIPTION**

The 2SK3113 is N-channel DMOS FET device that features a low gate charge and excellent switching characteristic, and designed for high voltage applications such as switching power supply, AC adapter.

#### **★ ORDERING INFORMATION**

PART NUMBER	PACKAGE		
2SK3113	TO-251 (MP-3)		
2SK3113-Z	TO-252 (MP-3Z)		

#### **FEATURES**

- Low on-state resistance
- $R_{DS(on)} = 4.4 \Omega MAX. (V_{GS} = 10 V, I_D = 1.0 A)$
- Low gate charge

 $Q_G = 9 \text{ nC TYP.}$  ( $V_{DD} = 450 \text{ V}$ ,  $V_{GS} = 10 \text{ V}$ ,  $I_D = 2.0 \text{ A}$ )

- Gate voltage rating ±30 V
- Avalanche capability ratings

(TO-251)

#### ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (V <sub>GS</sub> = 0 V)	VDSS	600	V
Gate to Source Voltage (VDS = 0 V)	Vgss	±30	V
Drain Current (DC) (Tc = 25°C)	ID(DC)	±2.0	Α
Drain Current (pulse) Note1	ID(pulse)	±8.0	Α
Total Power Dissipation (Tc = 25°C)	P <sub>T1</sub>	20	W
Total Power Dissipation (T <sub>A</sub> = 25°C) Note2	P <sub>T2</sub>	1.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to +150	°C
Single Avalanche Current Note3	las	2.0	Α
Single Avalanche Energy Note3	Eas	2.7	mJ



(TO-252)



- **Notes 1.** PW  $\leq$  10  $\mu$ s, Duty Cycle  $\leq$  1%
  - 2. Mounted on glass epoxy board of 40 mm x 40 mm x 1.6 mm
  - 3. Starting T<sub>ch</sub> = 25°C, V<sub>DD</sub> = 150 V, R<sub>G</sub> = 25  $\Omega$ , V<sub>GS</sub> = 20  $\rightarrow$  0 V

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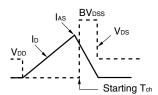


## **ELECTRICAL CHARACTERISTICS (TA = 25°C)**

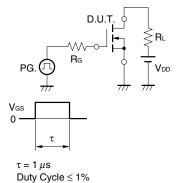
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = 600 V, V <sub>GS</sub> = 0 V			100	μΑ
Gate Leakage Current	lgss	V <sub>GS</sub> = ±30 V, V <sub>DS</sub> = 0 V			±10	μΑ
Gate Cut-off Voltage	V <sub>GS(off)</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	2.5		3.5	V
Forward Transfer Admittance	<b>y</b> fs	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1.0 A	0.5			S
Drain to Source On-state Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 1.0 A		3.3	4.4	Ω
Input Capacitance	Ciss	V <sub>DS</sub> = 10 V		290		pF
Output Capacitance	Coss	V <sub>GS</sub> = 0 V		60		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		5		pF
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 150 V, I <sub>D</sub> = 1.0 A		7		ns
Rise Time	tr	V <sub>GS</sub> = 10 V		2		ns
Turn-off Delay Time	<b>t</b> d(off)	$R_G = 10 \Omega$ , $R_L = 10 \Omega$		22		ns
Fall Time	t <sub>f</sub>			9		ns
Total Gate Charge	Q <sub>G</sub>	V <sub>DD</sub> = 450 V		9		nC
Gate to Source Charge	Q <sub>G</sub> s	V <sub>GS</sub> = 10 V		2.4		nC
Gate to Drain Charge	Q <sub>GD</sub>	I <sub>D</sub> = 2.0 A		2		nC
Body Diode Forward Voltage	V <sub>F(S-D)</sub>	I <sub>F</sub> = 2.0 A, V <sub>GS</sub> = 0 V		0.9		V
Reverse Recovery Time	trr	I <sub>F</sub> = 2.0 A, V <sub>GS</sub> = 0 V		0.9		μs
Reverse Recovery Charge	Qrr	$di/dt = 50 A/\mu s$		2.0		μC

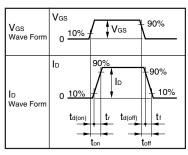
#### **TEST CIRCUIT 1 AVALANCHE CAPABILITY**

# $\begin{array}{c} \text{D.U.T.} \\ \text{Rg} = 25 \ \Omega \\ \text{PG.} \\ \hline \geqslant 50 \ \Omega \\ \end{array}$



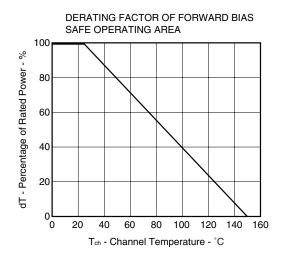
#### **TEST CIRCUIT 2 SWITCHING TIME**

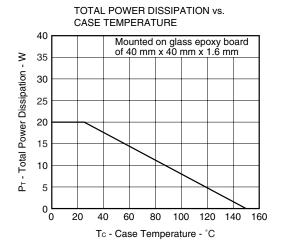




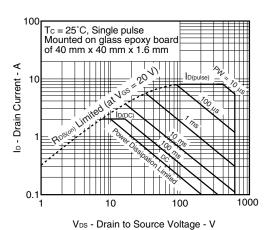
## **TEST CIRCUIT 3 GATE CHARGE**

#### **★ TYPICAL CHARACTERISTICS (TA = 25°C)**

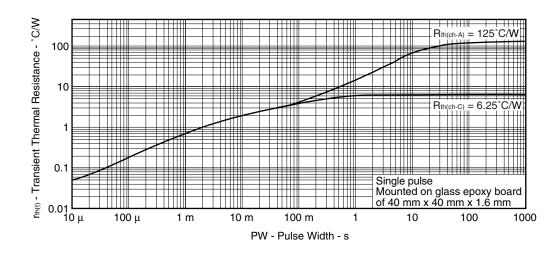




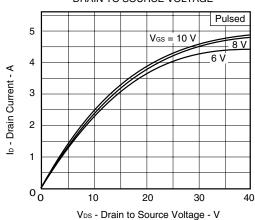
#### FORWARD BIAS SAFE OPERATING AREA



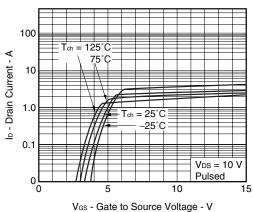
## TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



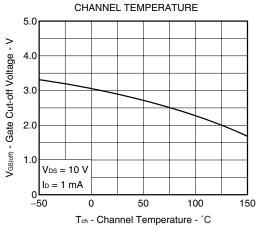
# DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



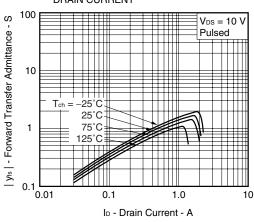
# FORWARD TRANSFER CHARACTERISTICS



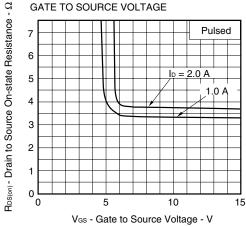
## GATE CUT-OFF VOLTAGE vs.



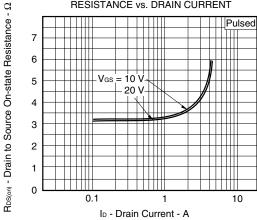
# FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

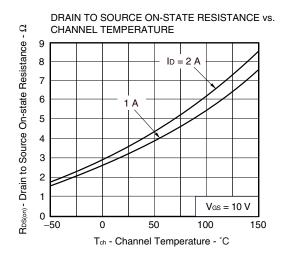


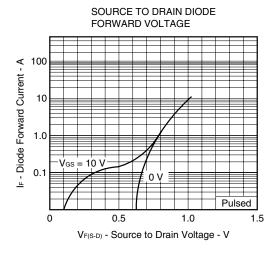
# DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

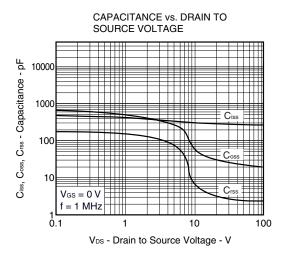


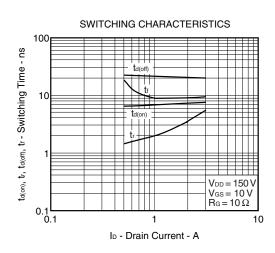
# DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

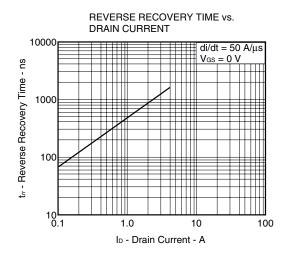


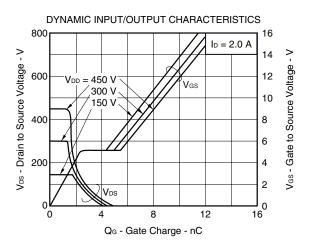


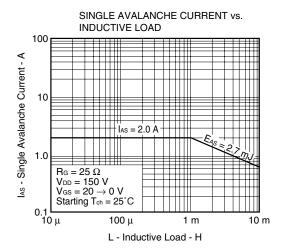


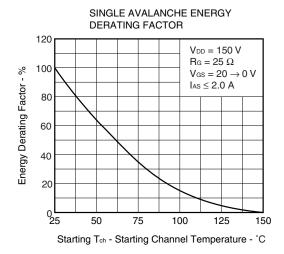




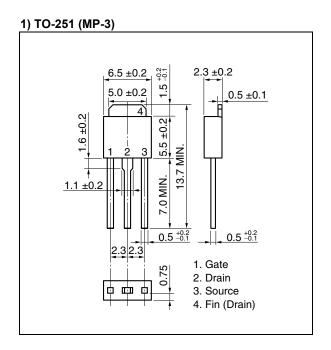


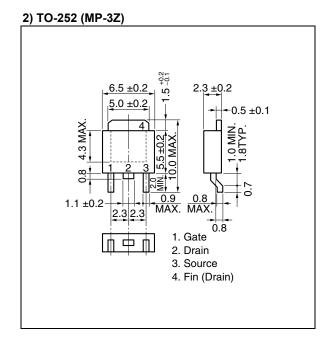




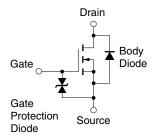


#### **★ PACKAGE DRAWINGS (Unit: mm)**





## **EQUIVALENT CIRCUIT**



**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD.

When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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